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**NTE2970  
MOSFET  
N-Channel, Enhancement Mode  
High Speed Switch  
TO3P Type Package**

**Features:**

- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current
- Lower  $R_{DS(ON)}$

**Applications:**

- SMPS
- DC-DC Converter
- Battery Charger
- Power Supply of Printer
- Copier
- HDD, FDD, TV, VCR
- Personal Computer

**Absolute Maximum Ratings:**

Drain-Source Voltage, $V_{DSS}$ .....	500V
Drain Current, Continuous, $I_D$ $T_C = +25^\circ C$ .....	22A
$T_C = +100^\circ C$ .....	13.4A
Drain Current, Pulsed (Note 1), $I_{DM}$ .....	88A
Gate-Source Voltage, $V_{GS}$ .....	$\pm 30V$
Single Pulsed Avalanche Energy (Note 2), $E_{AS}$ .....	2151mJ
Avalanche Current (Note 1), $I_{AR}$ .....	22A
Repetitive Avalanche Energy (Note 1), $E_{AR}$ .....	27.8mJ
Peak Diode Recovery $dv/dt$ (Note 3), $dv/dt$ .....	3.5V/ns
Total Power Dissipation ( $T_C = +25^\circ C$ ), $P_D$ .....	278W
Linear Derating Factor .....	2.22W/ $^\circ C$
Operating Junction Temperature Range, $T_J$ .....	-55° to +150° $^\circ C$
Storage Temperature Range, $T_{stg}$ .....	-55° to +150° $^\circ C$
Lead Temperature (During Soldering, 1/8" from case, 5 sec.), $T_L$ .....	+300° $^\circ C$
Maximum Thermal Resistance, Junction-to-Case, $R_{thJC}$ .....	0.45° $^\circ C/W$
Typical Thermal Resistance, Case-to-Sink, $R_{thCS}$ .....	0.24° $^\circ C/W$
Maximum Thermal Resistance, Junction-to-Ambient, $R_{thJA}$ .....	40° $^\circ C/W$

Note 1. Repetitive Rating: Pulse Width limited by Maximum Junction Temperature.

Note 2.  $L = 8mH$ ,  $I_{AS} = 22A$ ,  $V_{DD} = 50V$ ,  $R_G = 27\Omega$ , Starting  $T_J = +25^\circ C$ .

Note 3.  $I_{SD} \leq 22A$ ,  $di/dt \leq 300A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ , Starting  $T_J = +25^\circ C$ .

**Electrical Characteristics:** ( $T_C = +25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain–Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250^\circ\text{A}$	500	—	—	V
Breakdown Voltage Temperature Coefficient	$\pm B_V/\pm T_J$	$I_D = 250^\circ\text{A}$	—	0.69	—	$\text{V}/^\circ\text{C}$
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = 5\text{V}$ , $I_D = 250^\circ\text{A}$	2.0	—	4.0	V
Gate–Source Leakage	$I_{\text{GSS}}$	$V_{\text{GS}} = \pm 30\text{V}$	—	—	$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = 500\text{V}$	—	—	10	$^\circ\text{A}$
		$V_{\text{DS}} = 400\text{V}$ , $T_C = +125^\circ\text{C}$	—	—	100	$^\circ\text{A}$
Static Drain–Source ON Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10\text{V}$ , $I_D = 11\text{A}$ , Note 4	—	—	0.25	$\leq$
Forward Transconductance	$g_{\text{fs}}$	$V_{\text{DS}} = 50\text{V}$ , $I_D = 11\text{A}$ , Note 4	—	17.31	—	mhos
Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 25\text{V}$ , $f = 1\text{MHz}$	—	3940	5120	pF
Output Capacitance	$C_{\text{oss}}$		—	465	535	pF
Reverse Transfer Capacitance	$C_{\text{rss}}$		—	215	250	pF
Turn–On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 200\text{V}$ , $I_D = 22\text{A}$ , $V_{\text{GS}} = 10\text{V}$ , $R_G = 5.3\text{k}\Omega$ , Note 4, Note 5	—	27	65	ns
Rise Time	$t_r$		—	30	70	ns
Turn–Off Delay Time	$t_{\text{d}(\text{off})}$		—	150	310	ns
Fall Time	$t_f$		—	43	95	ns
Total Gate Charge	$Q_g$	$V_{\text{DS}} = 400\text{V}$ , $V_{\text{GS}} = 10\text{V}$ , $I_D = 22\text{A}$ , Note 4, Note 5	—	182	236	nC
Gate–Source Charge	$Q_{\text{gs}}$		—	26	—	nC
Gate–Drain (Miller) Charge	$Q_{\text{gd}}$		—	79.6	—	nC

**Source–Drain Diode Ratings and Characteristics**

Continuous Source Current	$I_S$	Integral Reverse PN-Diode in the MOSFET	—	—	22	A
Pulsed Source Current (Note 1)	$I_{\text{SM}}$		—	—	88	A
Diode Forward Voltage	$V_{\text{SD}}$	$T_J = +25^\circ\text{C}$ , $I_S = 22\text{A}$ , $V_{\text{GS}} = 0\text{V}$	—	—	1.4	V
Reverse Recovery Time	$t_{\text{rr}}$	$T_J = +25^\circ\text{C}$ , $I_F = 22\text{A}$ , $dI_F/dt = 100\text{A}/^\circ\text{s}$ , Note 4	—	528	—	ns
Reverse Recovery Charge	$Q_{\text{rr}}$		—	8.35	—	$^\circ\text{C}$

Note 1. Repetitive Rating: Pulse Width limited by Maximum Junction Temperature.

Note 4. Pulse Test: Pulse Width =  $250^\circ\text{s}$ , Duty Cycle  $\leq 2\%$ .

Note 5. Essentially Independent of Operating Temperature.



